

TIMA[®] 5



Thermal Interface Material Analyzer

Model 5

The first convenient automated all-in-one

Simple yet versatile

TIMA is a comprehensive laboratory and industrial measurement tool providing a wide range of thermal measurements and analyses to be performed with highest scientific standard.

- Greases and pastes
- Cured gap fillers and adhesives
- Anisotropic composites
- Phase change materials
- Overall thermal resistance
- ▶ Effective thermal conductivity
- Thermal interface resistance
- ▶ Bulk thermal conductivity
- Curing parameters study
- ▶ Boundary conditions study
- In-situ reliability investigation
- Extreme conditions testing







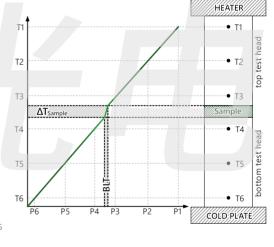


↑↓ test head

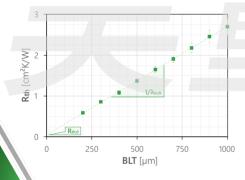
ASTM D 5470 Standard Conforming and Beyond

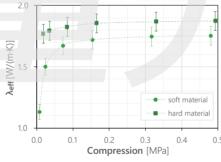
TIMA 5 fully meets the established test methodology described in ASTM Standard D 5470-17, while also providing fully automated characterization and many additional features not described in the ASTM Standard.

- ► Full coverage of specification range
- Fully automated measurement
- Up to 150°C sample temperature
- ▶ ± 300 N clamping and tensile force
- Scientific standard accuracy estimation
- ► Highly user-friendly, robust, and reliable

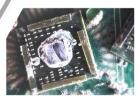


expansion



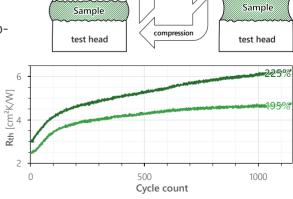


Ageing and Reliability Investigations



TIMA allows accelerated lifetime testing for thermal interface materials exposed to thermomechanical stress by emulating mechanical strain from in-field application.

- In-situ monitoring of aging / degradation
- Highly accelerated:500 cycles per day
- Application-related testing conditions
- Thickness- and pressurecontrolled cycling



↑↓ test head





Description

TIMA is a fully ASTM D 5470 compliant measurement system for thermal characterization of thermal interface material and other material with low to mid-ranged thermal conductivity.

Technical Specification

System

System type	Benchtop material characterization system				
Footprint (w × d)	35 × 40	cm ²			
Height	75	cm			
Weight	50	kg			
	100 230	VAC			
Power supply	50 60	Hz			
	600	W			

Measurement

Measurement type	Thermal steady-state cha	Thermal steady-state characterization				
Applied standards	ASTM D 5470-	ASTM D 5470-17				
	Thermal resistance	mm²K/W				
Output	Thermal conductivity	W/(m·K)				
	Thermal interface resistance	mm²K/W				
Resolution	1.0	mm ² K/W				

Sample properties

	min	max	
Sample size (round, diameter)	13	25.4	mm
Sample size (square, edge length)	10	25.4	mm
Sample thickness	< 0.001	10.0	mm

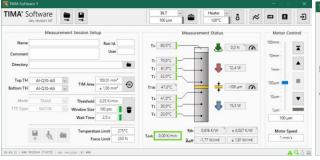
Measurement conditions

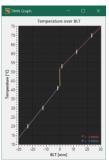
Force (continuous)	-300 .	N	
Force (short-term)	-450 .	N	
	= 40	4.5	MPa
Durant (also et Asses)	□ 10 mm	652	Psi
Pressure (short-term)	Ø 25 4 mama	0.9	MPa
	Ø 25.4 mm	130	Psi
Sample Temperature	20 150		°C

Measurement accuracy

Sensor temperatur	es	± 0.2	K	
Sample temperatur	re	± 0.05	K	
Sample thickness	load-free	± 1*	μm	
	force load of x N	± 2 * 0.02x	μm	
Mechanical load		± 1	N	
Thermal resistance		< ± 5	%	

Software screenshots





Key features

- » Full ASTM D 5470 compliance
- » Compact and all-in-one
- » Automated & scheduled testing
- » Swiftly exchangeable test heads
- » High precision thickness monitoring
- » Ease of use, optimized for user experience

Key output material and compound properties

- » Thermal resistance
- » Bulk thermal conductivity
- » Thermal interface resistance

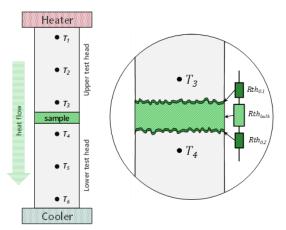
Key testing schemes

- » Temperature dependency
- » Pressure dependency
- » Thermal performance
- » Interface quality
- » Thermo-mechanical stability
- » Aging behavior / life expectation

Scope of samples

- » Thermal interface material
- » Pastes and greases
- » Gap pads and gap filler
- » Foils and sheets
- » Adhesive and cured material
- » Mold compound
- » Underfiller
- » Substrates and interposer

The principle of ASTM D 5470



Samples are measured between two metal test heads that are known in geometry and physical properties. Measuring both temperature gradient ΔT over and heat flow Q through the sample returns its effective thermal resistance Rtheff.

Repeating such measurement for multiple sample thicknesses allows to calculate the following linear fit to receive the sample's bulk thermal conductivity.

Linear fit of Rth over BLT

Thermal resistance Rth
$$\sim \frac{1}{\lambda_{bulk}}$$

$$Rth_{eff} = Rth_{bulk} + Rth_0$$

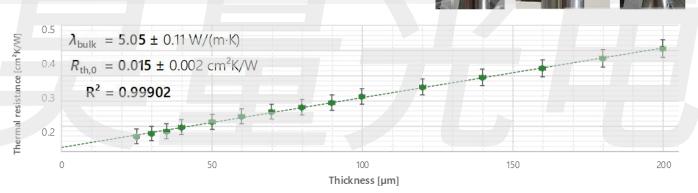
$$Rth_{eff} = \frac{\Delta T}{Q}$$

$$Rth_{eff} = \frac{1}{\lambda_{bulk} \cdot A} \cdot BLT + Rth_0$$

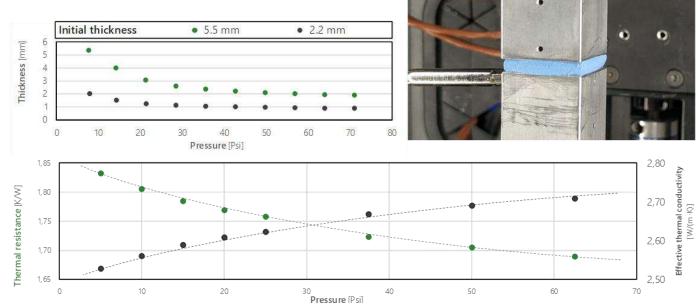
The linear fit over the thickness bears information about bulk thermal conductivity and thermal interface resistance.

Determination of bulk thermal conductivity

- Eff. thermal resistance over bond line thickness
 - → Bulk thermal conductivity and contact resistance
- Thickness range 25 to 200 µm
- 60°C sample temperature



Thermal characterization of soft material



Measurement deviation

Rth = $\Delta T / Q$		Q [W]	5	10	15	20	25	30	40	50
		dQ	5.0%	3.9%	3.6%	3.5%	3.4%	3.3%	3.3%	3.3%
ΔT [K]	dΔT	dRth								
1	10.5%		15.5%	14.4%	14.1%	14.0%	13.9%	13.8%	13.8%	13.8%
2	5.5%		10.5%	9.4%	9.1%	9.0%	8.9%	8.8%	8.8%	8.8%
5	2.5%		7.5%	6.4%	6.1%	6.0%	5.9%	5.8%	5.8%	5.8%
10	1.5%		6.5%	5.4%	5.1%	5.0%	4.9%	4.8%	4.8%	4.8%
15	1.2%		6.2%	5.1%	4.8%	4.7%	4.6%	4.5%	4.5%	4.5%
20	1.0%		6.0%	4.9%	4.6%	4.5%	4.4%	4.3%	4.3%	4.3%
25	0.9%		5.9%	4.8%	4.5%	4.4%	4.3%	4.2%	4.2%	4.2%
30	0.8%		5.8%	4.7%	4.4%	4.3%	4.2%	4.1%	4.1%	4.1%
40	0.8%		5.8%	4.7%	4.4%	4.3%	4.2%	4.1%	4.1%	4.1%
50	0.7%		5.7%	4.6%	4.3%	4.2%	4.1%	4.0%	4.0%	4.0%
60	0.7%		5.7%	4.6%	4.3%	4.2%	4.1%	4.0%	4.0%	4.0%
70	0.7%		5.7%	4.6%	4.3%	4.2%	4.1%	4.0%	4.0%	4.0%
90	0.6%		5.6%	4.5%	4.2%	4.1%	4.0%	3.9%	3.9%	3.9%
100	0.6%		5.6%	4.5%	4.2%	4.1%	4.0%	3.9%	3.9%	3.9%

